H-Bridge in APM16 Series for LLC and Phase-shifted DC-DC Converter

NXV65HR82DS1, NXV65HR82DS2, NXV65HR82DZ1, NXV65HR82DZ2

ON Semiconductor®

Features
- SIP or DIP H−Bridge Power Module for On−board Charger (OBC) in EV or PHEV
- 5 kV/1 s Electrically Isolated Substrate for Easy Assembly
- Creepage and Clearance per IEC60664−1, IEC 60950−1
- Compact Design for Low Total Module Resistance
- Module Serialization for Full Traceability
- Lead Free, RoHS and UL94V−0 Compliant
- Automotive Qualified per AEC Q101 and AQG324 Guidelines

Applications
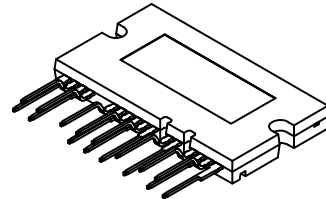- DC−DC Converter for On−board Charger in EV or PHEV

Benefits
- Enable Design of Small, Efficient and Reliable System for Reduced Vehicle Fuel Consumption and CO_2 Emission
- Simplified Assembly, Optimized Layout, High Level of Integration, and Improved Thermal Performance
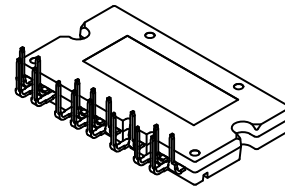

APMCA−A16
16 LEAD
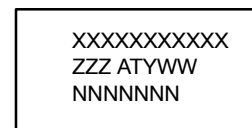**CASE MODGF**

APMCA−B16
16 LEAD
CASE MODGJ

MARKING DIAGRAM

XXXXXXXXXX
ZZZ ATYWW
NNNNNNN

XXXX = Specific Device Code
ZZZ = Lot ID
AT   = Assembly & Test Location
Y   = Year
W   = Work Week
NNN = Serial Number

ORDERING INFORMATION
See detailed ordering, marking and shipping information on page 10 of this data sheet.

April, 2021 – Rev. 2

Pin Configuration and Block Diagram
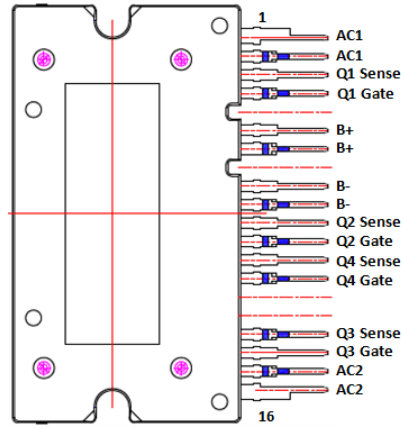
Figure 1. Pin Configuration

Table 1. PIN DESCRIPTION

Pin Number	Pin Name	Pin Description
1, 2	AC1	Phase 1 Leg of the H−Bridge
3	Q1 Sense	Source Sense of Q1
4	Q1 Gate	Gate Terminal of Q1
5, 6	B+	Positive Battery Terminal
7, 8	B−	Negative Battery Terminal
9	Q2 Sense	Source Sense of Q2
10	Q2 Gate	Gate Terminal of Q2
11	Q4 Sense	Source Sense of Q4
12	Q4 Gate	Gate Terminal of Q4
13	Q3 Sense	Source Sense of Q3
14	Q3 Gate	Gate Terminal of Q3
15, 16	AC2	Phase 2 Leg of the H−Bridge

Block Diagram
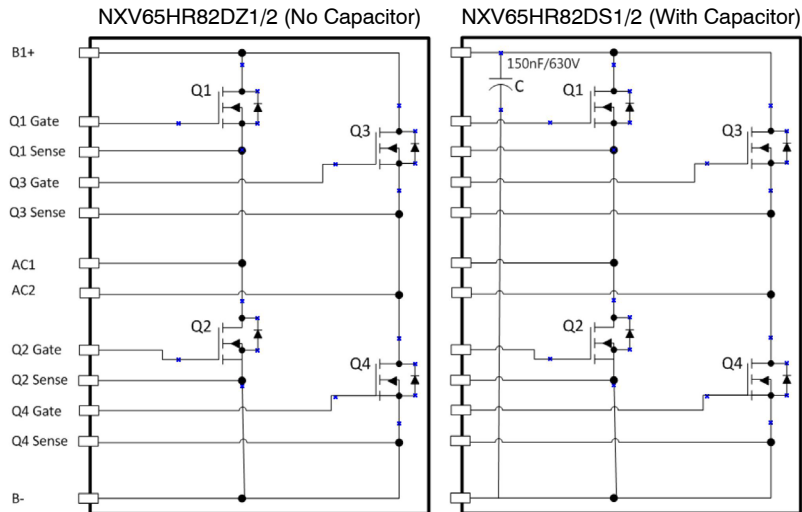
Figure 2. Schematic

Table 2. ABSOLUTE MAXIMUM RATINGS (T_J = 25°C, Unless Otherwise Specified)

Symbol	Parameter	Max	Unit
V_{DS} (Q1~Q4)	Drain−to−Source Voltage	650	V
V_{GS} (Q1~Q4)	Gate−to−Source Voltage	±20	V
I_D (Q1~Q4)	Drain Current Continuous (T_C = 25°C, V_{GS} = 10 V) (Note 1)	26	A
	Drain Current Continuous (T_C = 100°C, V_{GS} = 10 V) (Note 1)	17	A
P_D	Power Dissipation (Note 1)	126	W
T_J	Maximum Junction Temperature	−55 to +150	°C
T_C	Maximum Case Temperature	−40 to +125	°C
T_{STG}	Storage Temperature	−40 to +125	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
1. Maximum continuous current and power, without switching losses, to reach T_J = 150°C respectively at T_C = 25°C and T_C = 100°C; defined by design based on MOSFET $R_{DS(ON)}$ and $R_{\theta JC}$ and not subject to production test

Table 3. SINGLE PULSE AVALANCHE ENERGY

Symbol	Parameter	Max	Unit
E_{AS} (Q1~Q4)	Single Pulsed Avalanche Energy (Note 2)	510	mJ
E_{AS} (Q1~Q4)	Single Pulsed Avalanche Energy (Note 2)	21	mJ
I_{AS}	Avalanche Current	4.8	A

2. 510 mJ is characterized at T_J = 25°C, L = 44.3 mH, I_{AS} = 4.8 A, V_{DD} = 145 V.
   21 mJ is 100% tested at T_J = 25°C, L = 1 mH, I_{AS} = 4.8 A, V_{DD} = 145 V.

Table 4. COMPONENTS (Note 3)

Device	Parameter	Condition	Min	Typ	Max	Unit
Capacitor (Snubber) AEC Q200 qualified	Capacitance	T_J = 25°C	135	150	165	nF
	Rated Voltage		–	630	–	V

3. These values are obtained from the specification provided by the manufacturer.

DBC Substrate

0.63 mm Al_2O_3 alumina with 0.3 mm copper on both sides. DBC substrate is NOT nickel plated.

Lead Frame

OFC copper alloy, 0.50 mm thick. Plated with 8 um to 25.4 um thick Matte Tin

Flammability Information

All materials present in the power module meet UL flammability rating class 94V−0.

Compliance to RoHS Directives

The power module is 100% lead free and RoHS compliant 2000/53/C directive.

Solder

Solder used is a lead free SnAgCu alloy.

Solder presents high risk to melt at temperature beyond 210°C. Base of the leads, at the interface with the package body, should not be exposed to more than 200°C during mounting on the PCB or during welding to prevent the re−melting of the solder joints.

Table 5. ELECTRICAL SPECIFICATIONS (T_J = 25°C, Unless Otherwise Specified)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
BV_{DSS}	Drain–to–Source Breakdown Voltage	I_D = 1 mA, V_{GS} = 0 V	650	–	–	V
$V_{GS(th)}$	Gate to Source Threshold Voltage	V_{GS} = V_{DS}, I_D = 0.97 mA	3.0	–	5.0	V
$R_{DS(ON)}$	Q1 – Q4 MOSFET On Resistance	V_{GS} = 10 V, I_D = 20 A	–	73	82	mΩ
$R_{DS(ON)}$	Q1 – Q4 MOSFET On Resistance	V_{GS} = 10 V, I_D = 20 A, T_J = 125°C (Note 4)	–	133	–	mΩ
g_{FS}	Forward Transconductance	V_{DS} = 20 V, I_D = 20 A (Note 4)	–	29	–	S
I_{GSS}	Gate–to–Source Leakage Current	V_{GS} = ±30 V, V_{DS} = 0 V	–100	–	+100	nA
I_{DSS}	Drain–to–Source Leakage Current	V_{DS} = 650 V, V_{GS} = 0 V	–	–	10	μA

DYNAMIC CHARACTERISTICS (Note 4)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
C_{iss}	Input Capacitance	V_{DS} = 400 V V_{GS} = 0 V f = 1 MHz	–	3608	–	pF
C_{oss}	Output Capacitance		–	72.3	–	pF
C_{rss}	Reverse Transfer Capacitance		–	5.56	–	pF
$C_{oss(eff)}$	Effective Output Capacitance	V_{DS} = 0 to 520 V V_{GS} = 0 V	–	448	–	pF
R_g	Gate Resistance	f = 1 MHz	–	1.7	–	Ω
$Q_{g(tot)}$	Total Gate Charge	V_{DS} = 380 V I_D = 20 A V_{GS} = 0 to 10 V	–	79.7	–	nC
Q_{gs}	Gate–to–Source Gate Charge		–	24.9	–	nC
Q_{gd}	Gate–to–Drain "Miller" Charge		–	31.9	–	nC

SWITCHING CHARACTERISTICS (Note 4)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
t_{on}	Turn–on Time	V_{DS} = 400 V I_D = 20 A V_{GS} = 10 V R_G = 4.7 Ω	–	96	–	ns
$t_{d(on)}$	Turn–on Delay Time		–	54	–	ns
t_r	Turn–on Rise Time		–	42	–	ns
t_{off}	Turn–off Time		–	117	–	ns
$t_{d(off)}$	Turn–off Delay Time		–	84	–	ns
t_f	Turn–off Fall Time		–	33	–	ns

BODY DIODE CHARACTERISTICS

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{SD}	Source–to–Drain Diode Voltage	I_{SD} = 20 A, V_{GS} = 0 V	–	1.1	–	V
T_{rr}	Reverse Recovery Time	V_{DS} = 520 V, I_D = 20 A, dI/dt = 100 A/μs (Note 4)	–	107	–	ns
Q_{rr}	Reverse Recovery Charge		–	430	–	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
4. Defined by design, not subject to production test

Table 6. THERMAL RESISTANCE

Parameters		Min	Typ	Max	Unit
$R_{θJC}$ (per chip)	Q1~Q4 Thermal Resistance Junction–to–Case (Note 5)	–	0.7	0.99	°C/W
$R_{θJS}$ (per chip)	Q1~Q4 Thermal Resistance Junction–to–Sink (Note 6)	–	1.32	–	°C/W

5. Test method compliant with MIL STD 883–1012.1, from case temperature under the chip to case temperature measured below the package at the chip center, Cosmetic oxidation and discoloration on the DBC surface allowed
6. Defined by thermal simulation assuming the module is mounted on a 5 mm Al–360 die casting material with 30 um of 1.8 W/mK thermal interface material

Table 7. ISOLATION (Isolation resistance at tested voltage from the base plate to control pins or power terminals.)

Test	Test Conditions	Isolation Resistance	Unit
Leakage @ Isolation Voltage (Hi–Pot)	V_{AC} = 5 kV, 50 Hz	100M <	Ω

PARAMETER DEFINITIONS

Reference to Table 5: Parameter of Electrical Specifications

BV_{DSS}	Q1 − Q4 MOSFET Drain−to−Source Breakdown Voltage The maximum drain−to−source voltage the MOSFET can endure without the avalanche breakdown of the body− drain P−N junction in off state. The measurement conditions are to be found in Table 5. The typ. Temperature behavior is described in Figure 13
$V_{GS(th)}$	Q1 − Q4 MOSFET Gate to Source Threshold Voltage The gate−to−source voltage measurement is triggered by a threshold ID current given in conditions at Table 11. The typ. Temperature behavior can be found in Figure 12
$R_{DS(ON)}$	Q1 − Q4 MOSFET On Resistance RDS(on) is the total resistance between the source and the drain during the on state. The measurement conditions are to be found in Table 5.} The typ behavior can be found in Figure 10 and Figure 11 as well as Figure 17
g_{FS}	Q1 − Q4 MOSFET Forward Transconductance Transconductance is the gain in the MOSFET, expressed in the Equation below. t describes the change in drain current by the change in the gate−source bias voltage: $g_{fs} = [-\Delta I_{DS} / \Delta V_{GS}]_{VDS}$
I_{GSS}	Q1 − Q4 MOSFET Gate−to−Source Leakage Current The current flowing from Gate to Source at the maximum allowed VGS The measurement conditions are described in the Table 5.
I_{DSS}	Q1 − Q4 MOSFET Drain−to−Source Leakage Current Drain − Source current is measured in off state while providing the maximum allowed drain−to−source voltage and the gate is shorted to the source. IDSS has a positive temperature coefficient.

Figure 3. Timing Measurement Variable Definition

Table 8. PARAMETER OF SWITCHING CHARACTERISTICS

Turn−On Delay ($t_{d(on)}$):	This is the time needed to charge the input capacitance, Ciss, before the load current ID starts flowing. The measurement conditions are described in the Table 5. For signal definition please check Figure 3 above.
Rise Time (t_r):	The rise time is the time to discharge output capacitance, Coss. After that time the MOSFET conducts the given load current ID. The measurement conditions are described in the Table 5. For signal definition please check Figure 3 above.
Turn−On Time (t_{on}):	Is the sum of turn−on−delay and rise time
Turn−Off Delay ($t_{d(off)}$):	td(off) is the time to discharge Ciss after the MOSFET is turned off. During this time the load current ID is still flowing The measurement conditions are described in the Table 5. For signal definition please check Figure 3 above.
Fall Time (t_f):	The fall time, tf, is the time to charge the output capacitance, Coss. During this time the load current drops down and the voltage VDS rises accordingly. The measurement conditions are described in the Table 5. For signal definition please check Figure 3 above.
Turn−Off Time (t_{off}):	Is the sum of turn−off−delay and fall time

NXV65HR82DS1, NXV65HR82DS2, NXV65HR82DZ1, NXV65HR82DZ2

TYPICAL CHARACTERISTICS
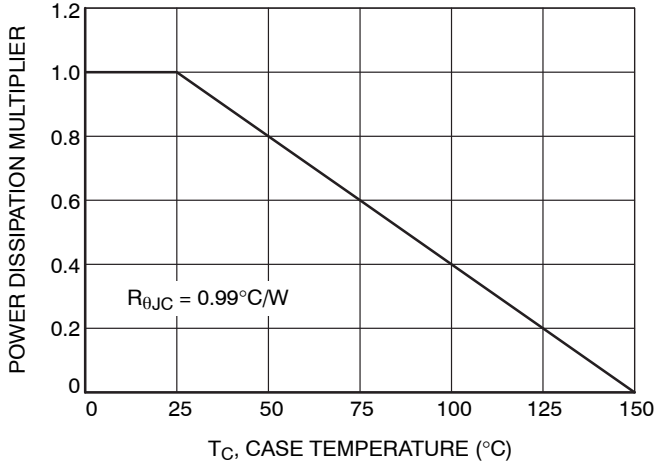
Figure 4. Normalized Power Dissipation vs. Case Temperature
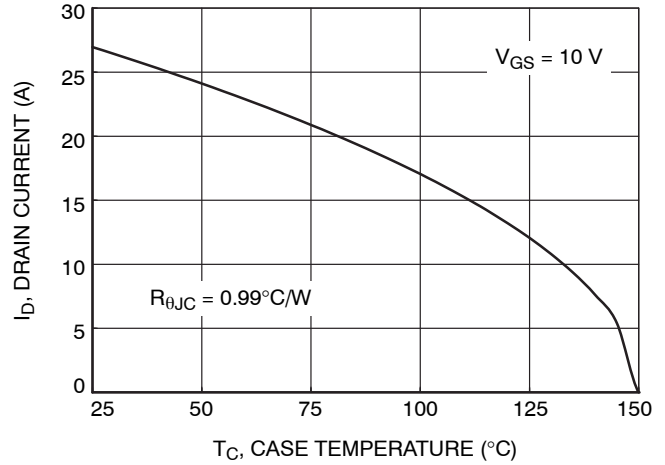
Figure 5. Maximum Continuous I$_D$ vs. Case Temperature
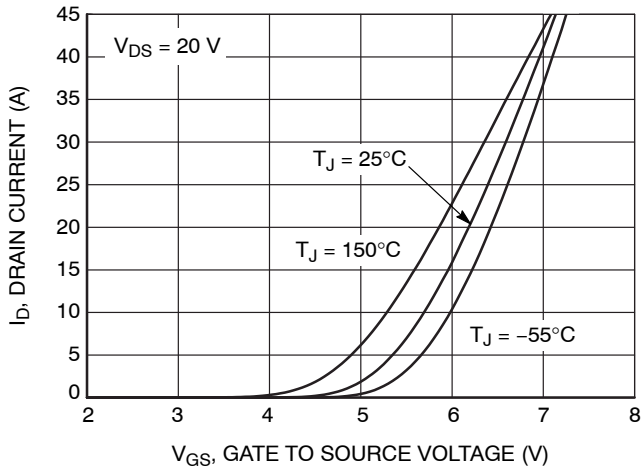
Figure 6. Transfer Characteristics
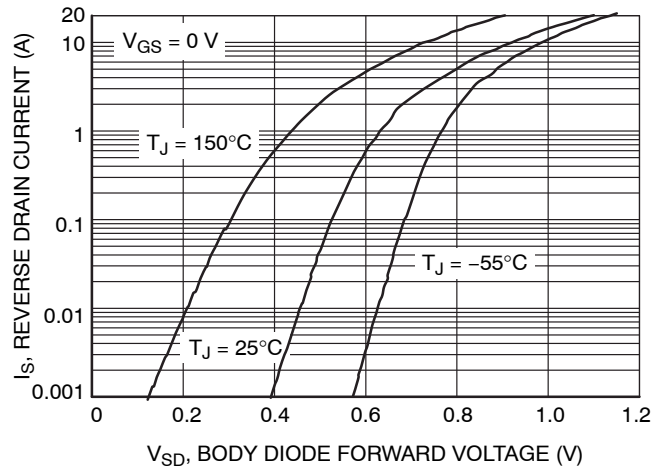
Figure 7. Forward Diode
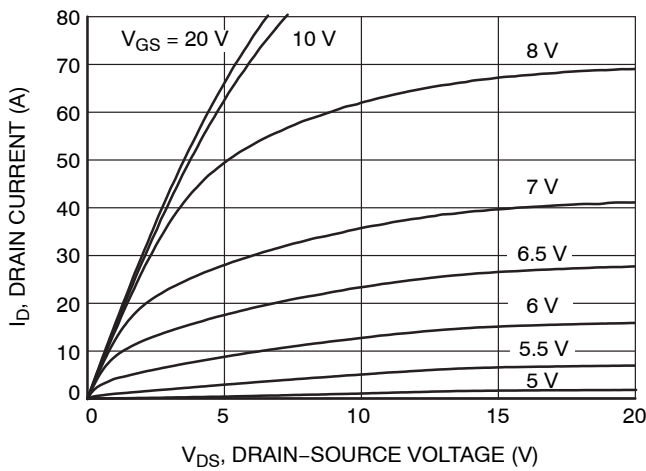
Figure 8. Saturation (25°C)
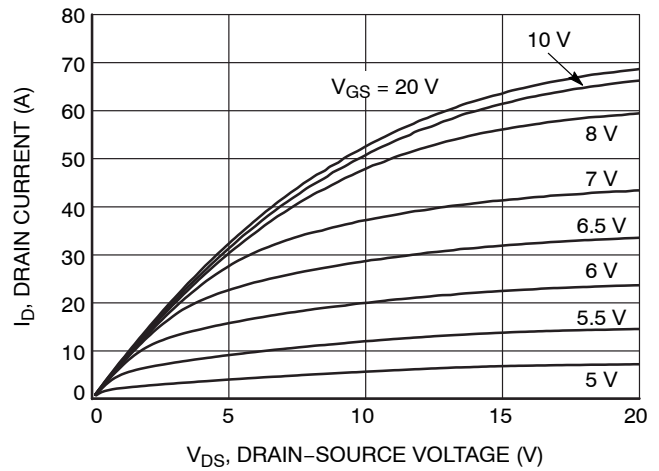
Figure 9. Saturation (150°C)

TYPICAL CHARACTERISTICS (continued)
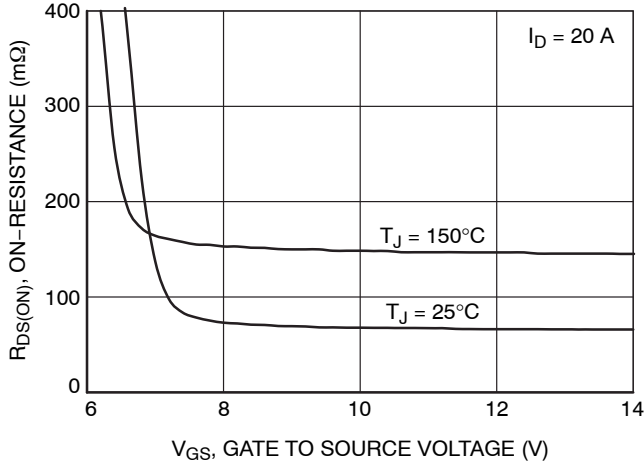
Figure 10. On−Resistance vs. Gate−to−Source Voltage
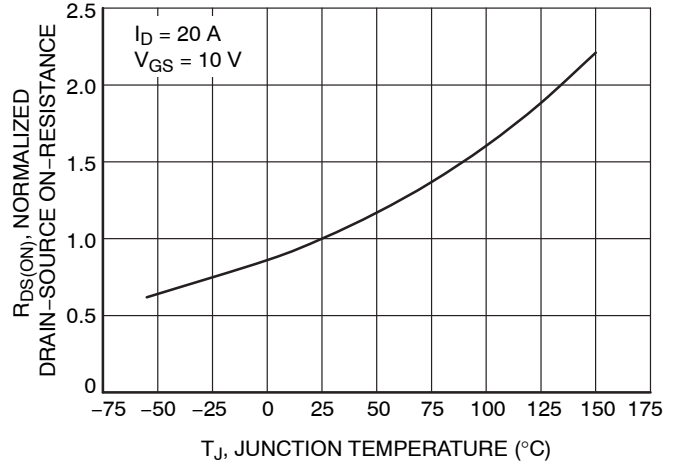
Figure 11. R$_{DS(norm)}$ vs. Junction Temperature
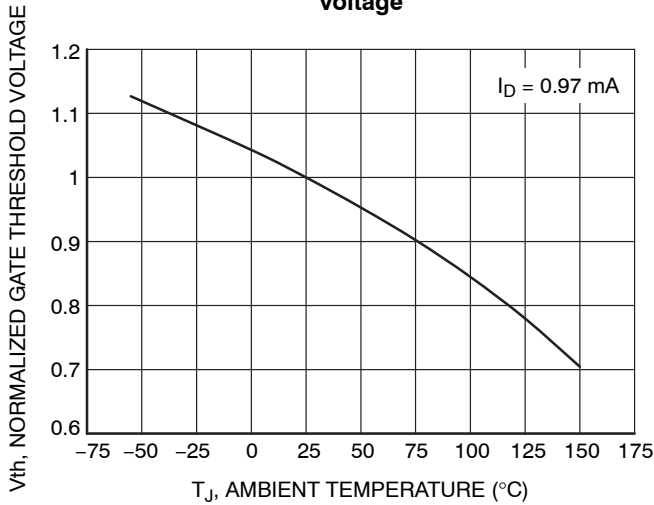
Figure 12. Normalized V$_{th}$ vs. Temperature
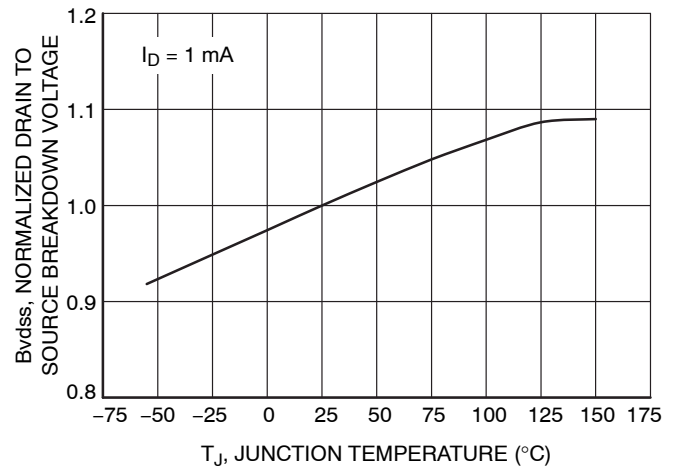
Figure 13. Breakdown Voltage vs. Temperature
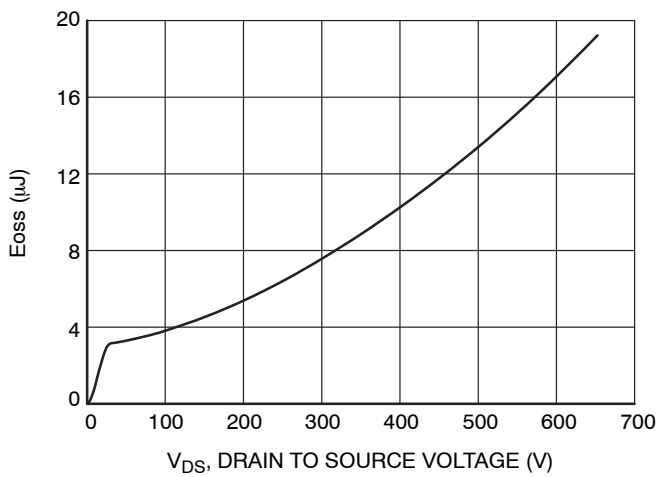
Figure 14. Eoss vs. Drain−to−Source Voltage
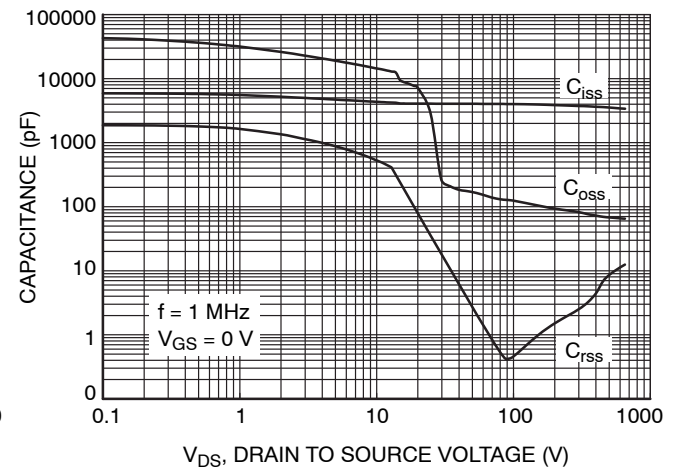
Figure 15. Capacitance Variation

TYPICAL CHARACTERISTICS (continued)
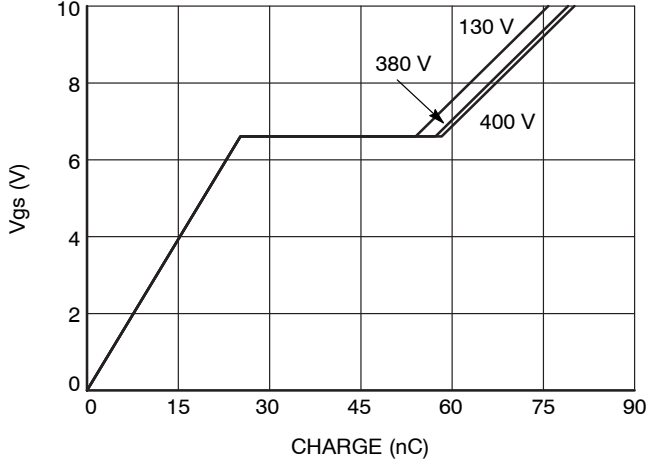
Figure 16. Gate Charge
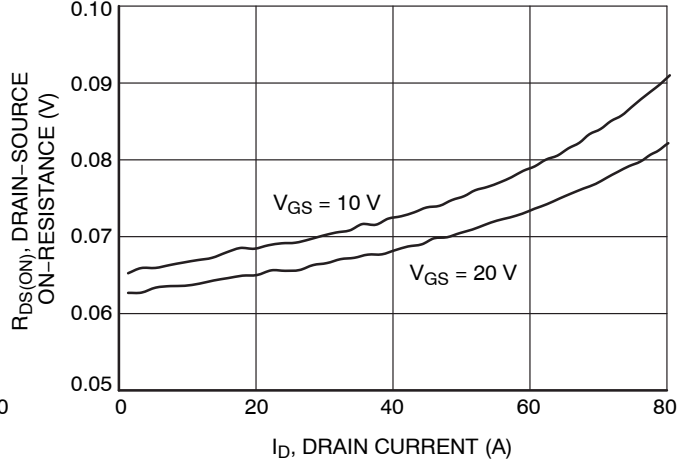
Figure 17. $R_{DS(ON)}$ vs. I_D
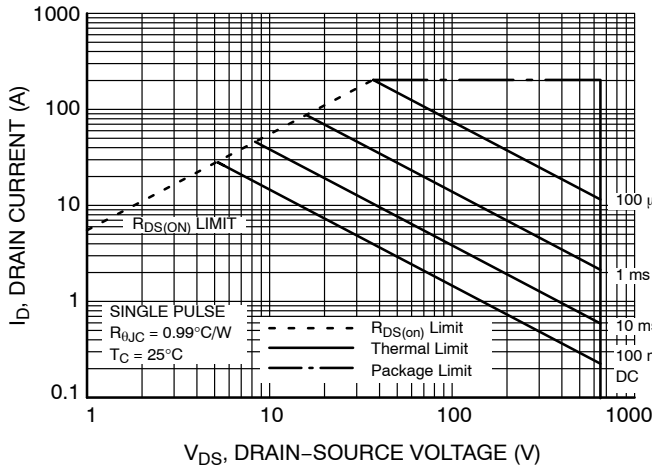
Figure 18. Safe Operating Area
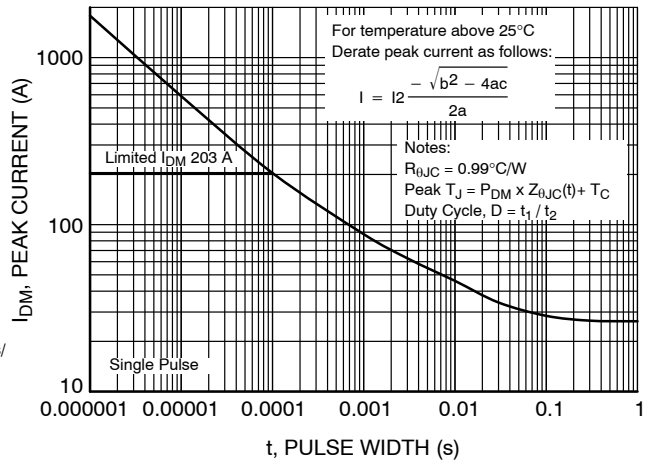
Figure 19. Peak Current Capability
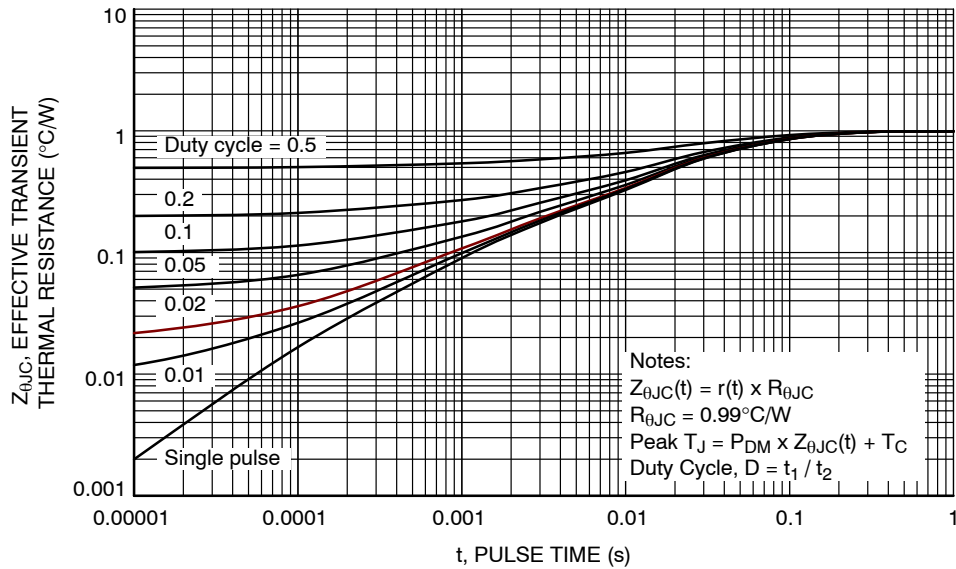
Figure 20. Transient Thermal Impedance

NXV65HR82DS1, NXV65HR82DS2, NXV65HR82DZ1, NXV65HR82DZ2

ORDERING INFORMATION

Part Number	Package	Lead Forming	Snubber Capacitor Inside	DBC Material	Pb−Free and RoHS Compliant	Operating Temperature (T_A)	Packing Method
NXV65HR82DS1	APM16−CAA	Y−Shape	Yes	Al_2O_3	Yes	−40°C~125°C	Tube
NXV65HR82DS2	APM16−CAB	L−Shape	Yes	Al_2O_3	Yes	−40°C~125°C	Tube
NXV65HR82DZ1	APM16−CAA	Y−Shape	No	Al_2O_3	Yes	−40°C~125°C	Tube
NXV65HR82DZ2	APM16−CAB	L−Shape	No	Al_2O_3	Yes	−40°C~125°C	Tube

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DATE 03 NOV 2021
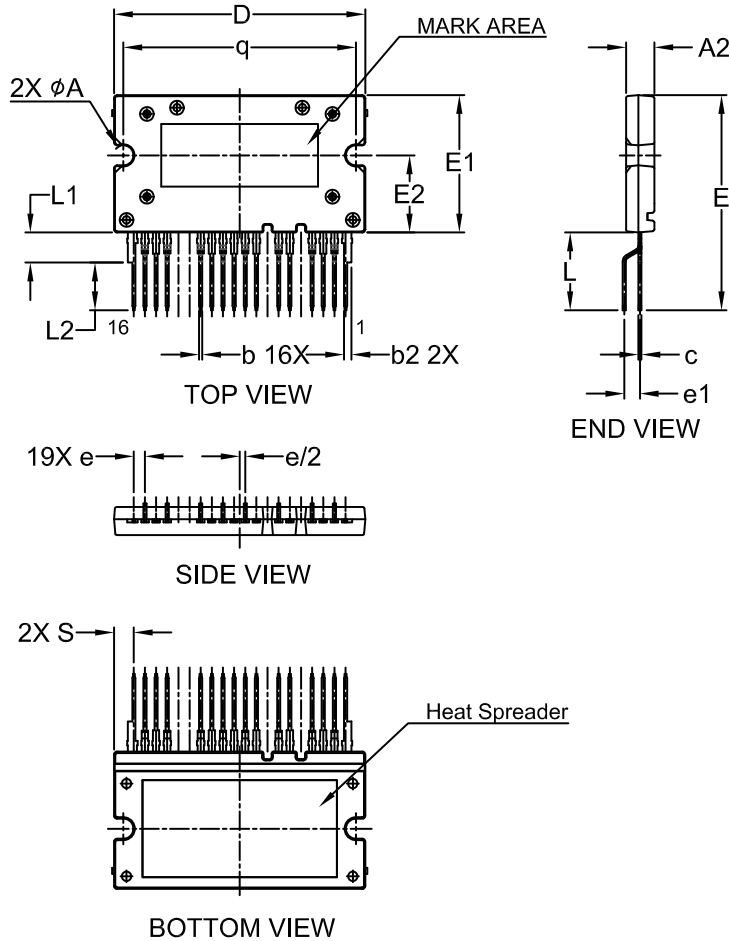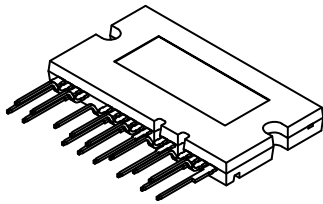
TOP VIEW

END VIEW
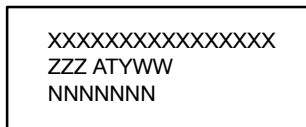
SIDE VIEW

BOTTOM VIEW

Heat Spreader

NOTES:

1. DIMENSIONING AND TOLERANCING PER. ASME Y14.5M, 2009.

2. CONTROLLING DIMENSION: MILLIMETERS

3. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR EXTRUSIONS.

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A2	4.30	4.50	4.70
b	0.45	0.50	0.60
b2	1.15	1.20	1.30
c	0.45	0.50	0.60
D	39.90	40.10	40.30
E	33.80	34.30	34.80
E1	21.70	21.90	22.10
E2	12.10	12.30	12.50
e	1.478	1.778	2.078
e1	2.20	2.50	2.80
L	12.10	12.40	12.70
L1	4.80 REF		
L2	7.30	7.60	7.90
q	36.85	37.10	37.35
S	3.159 REF		
φA	3.00	3.20	3.40

GENERIC MARKING DIAGRAM*

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XXXXXXXXXXXXXXXX
ZZZ ATYWW
NNNNNNN
```

XXXX = Specific Device Code
ZZZ = Lot ID
AT = Assembly & Test Location
Y = Year
W = Work Week
NNN = Serial Number

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, "G" or microdot "▪", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	APMCA−A16 / 16LD, AUTOMOTIVE MODULE	PAGE 1 OF 1

APMCA−B16 / 16LD, AUTOMOTIVE MODULE
CASE MODGJ
ISSUE C

DATE 03 NOV 2021
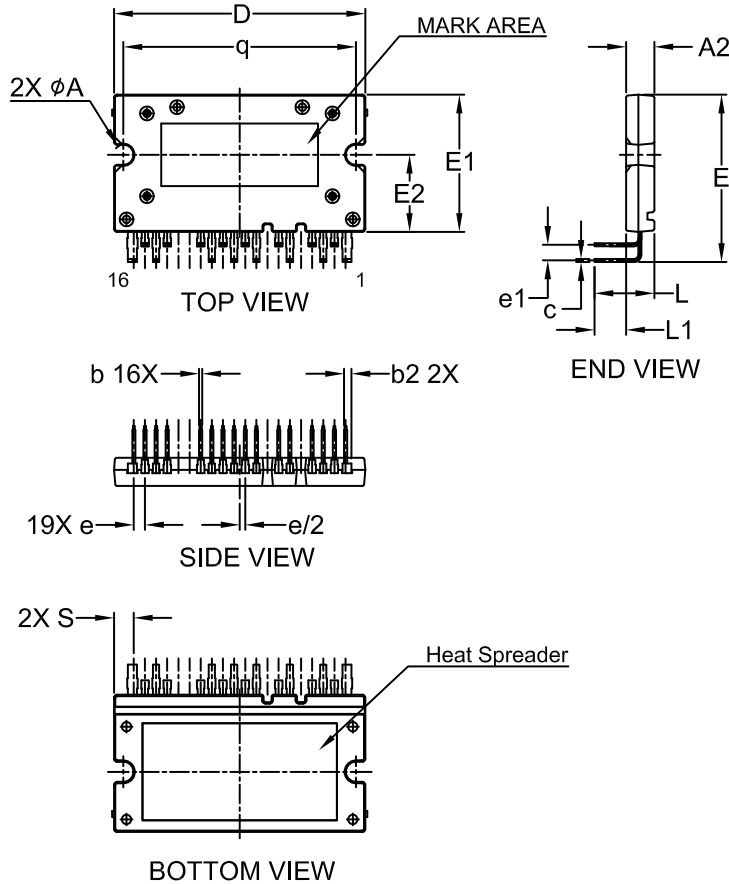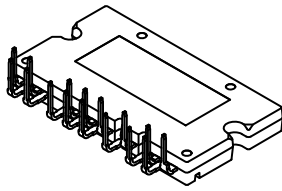
TOP VIEW

END VIEW

SIDE VIEW

BOTTOM VIEW

Heat Spreader

MARK AREA

NOTES:

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DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A2	4.30	4.50	4.70
b	0.45	0.50	0.60
b2	1.15	1.20	1.30
c	0.45	0.50	0.60
D	39.90	40.10	40.30
E	26.20	26.70	27.20
E1	21.70	21.90	22.10
E2	12.10	12.30	12.50
e	1.478	1.778	2.078
e1	2.20	2.50	2.80
L	9.20	9.55	9.90
L1	5.05 REF		
q	36.85	37.10	37.35
S	3.159 REF		
ϕA	3.00	3.20	3.40

GENERIC MARKING DIAGRAM*

XXXXXXXXXXXXXXXX
ZZZ ATYWW
NNNNNNN

XXXX = Specific Device Code
ZZZ = Lot ID
AT = Assembly & Test Location
Y = Year
W = Work Week
NNN = Serial Number

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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PUBLICATION ORDERING INFORMATION

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